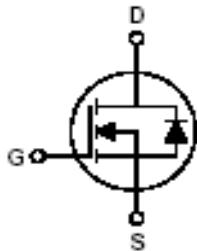
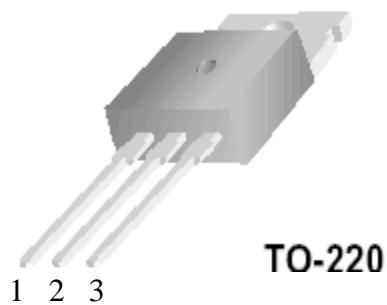


N Channel MOSFET

M02N60B

2.0A

PIN CONFIGURATION



1.Gate 2.Drain 3.Source

FEATURE

- Robust High Voltage Termination.
- Avalanche Energy Specified
- Source-to Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} and $V_{DS(on)}$ Specified at Elevated Temperature

ABSOLUTE MAXIMUM RATINGS

RATING	SYMBOL	VALUE	UNIT
Drain to Current - Continuous - Pulsed	I_D I_{DM}	2.0 9.0	A
Gate-to-Source Voltage – Continue - Non-repetitive	V_{GS} V_{GSM}	± 20 ± 40	V
Total Power Dissipation TO-251/252 TO-220	P_D	60 60	W
Operating and Storage Temperature Range	T_J , T_{STG}	-55 to 150	
Single Pulse Drain-to-Source Avalanche Energy – $T_j = 25$ ($V_{DD} = 100V$, $V_{GS} = 10V$, $I_{AS} = 2A$, $L = 10mH$, $R_G = 25\Omega$)	E_{AS}	20	mJ
Thermal Resistance – Junction to Case - Junction to Ambient	θ_{JC} θ_{JA}	1.0 62.5	/W
Maximum Lead Temperature for Soldering Purposes, 1/8" form 10 seconds	T_L	260	



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N Channel MOSFET**M02N60B****2.0A****MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS (Ta=25)**

PARAMETERS	SYMBOL	MIN	TYP	MAX	UNIT	CONDITION
Drain-Source Breakdown Voltage	V _{(BR)DSS}	600			Vdc	V _{GS} =0, I _D =250uA
Drain-Source Leakage Current	I _{DSS}			0.1 1.0	mA mA	V _{DS} =600V, V _{GS} =0 V _{DS} =480V, V _{GS} =0, T _j =125
Gate-Source Leakage Current-Forward	I _{GSSF}			100	nA	V _{GSF} =20V, V _{DS} =0
Gate Threshold Voltage	V _{GS(th)}	2.0		4.0	V	V _{DS} =V _{GS} , I _D =250uA
Drain-Source On-Resistance	R _{DSS(on)}			4.4	Ohm	V _{GS} =10V, I _D =1.2A*
Input Capacitance	C _{iss}		435		pF	V _{DS} =25V, V _{GS} =0, f=1 MHz
Output Capacitance	C _{oss}		56		pF	
Reverse Transfer Capacitance	C _{rss}		9.2		pF	
Turn-On Delay Time	t _{d(on)}		12		nS	V _{DD} =300V, I _D =2.0A, V _{GS} =10V, R _G =18
Turn-Off Delay Time	T _{d(off)}		30		nS	
Rise Time	t _r		21		nS	
Fall Time	t _f		24		nS	
Total Gate Charge	Q _g		13	22	nC	V _{DS} =400V, I _D =2.0A V _{GS} =10V*
Gate-Drain Charge	Q _{gd}		6.0		nC	
Gate-Drain Charge	Q _{gs}		2.0		nC	
Internal Drain Inductance	L _D		4.5		nH	Measured from the drain lead 0.25" From package to center of die
Internal Drain Inductance	L _s		7.5		nH	Measured from the source lead 0.25" form package to source bond pad

SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage(1)	V _{DS}		1.5	V	Is=2.0A, VGS=0V d _{IS} /d _t = 100A/ μ S
Forward Turn Time	t _{on}	**		nS	
Reverse Recovery Time	t _{rr}	340		nS	

*Pulse Test: Pulse Width 300 μ S, Duty Cycle 2%

**Negligible, Dominated by circuit inductance

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TYPICAL CHARACTERISTICS

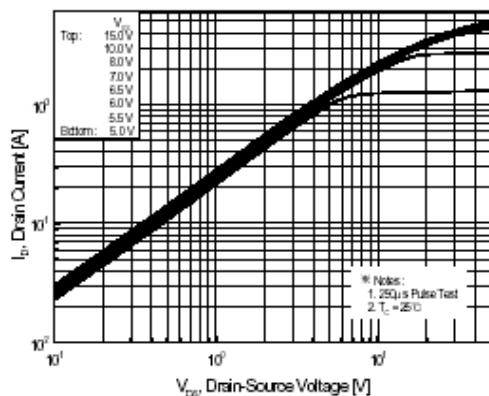


Figure 1. On-Region Characteristics

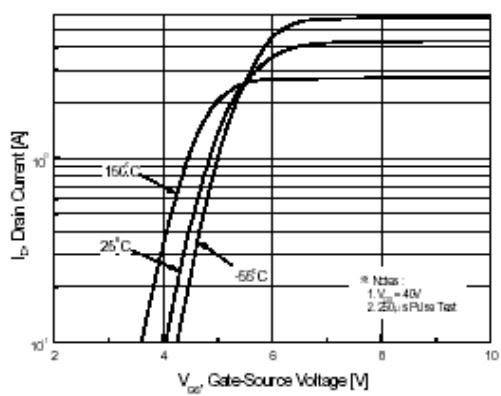


Figure 2. Transfer Characteristics

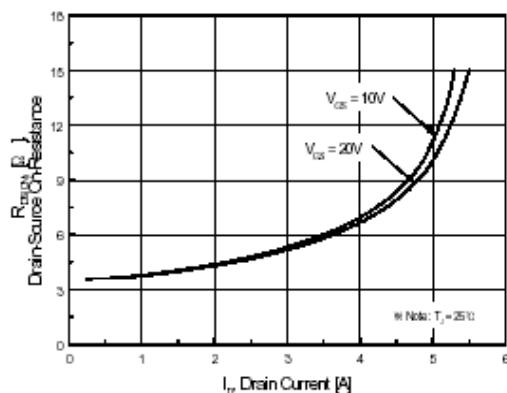


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

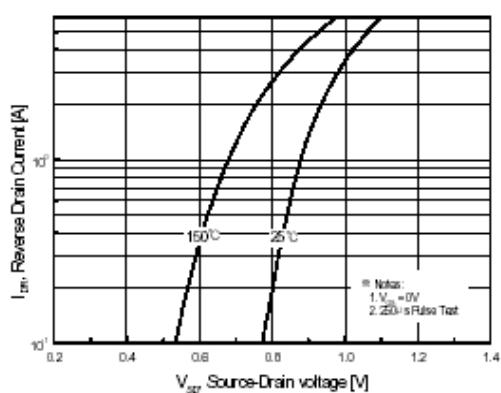


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

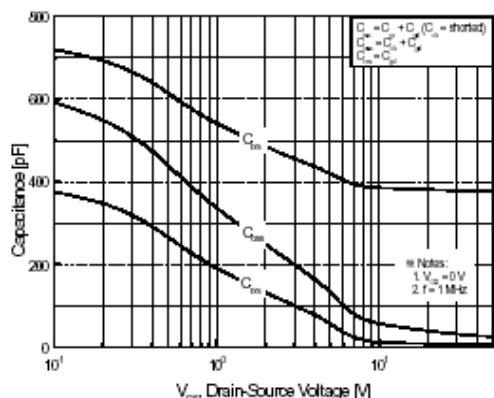


Figure 5. Capacitance Characteristics

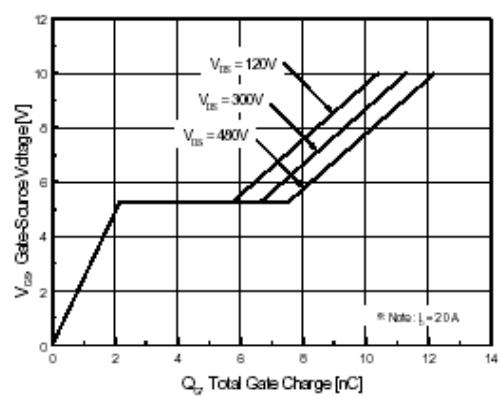


Figure 6. Gate Charge Characteristics

2.0A

TYPICAL CHARACTERISTICS (CONTINUED)

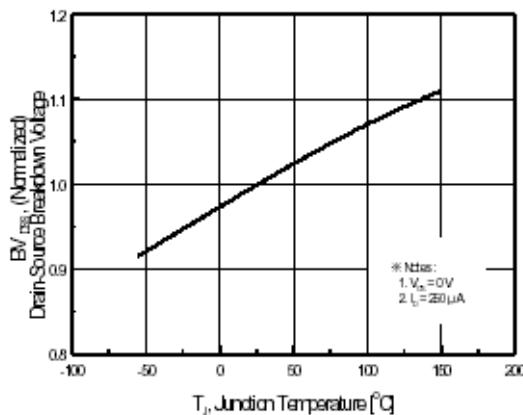


Figure 7. Breakdown Voltage Variation vs Temperature

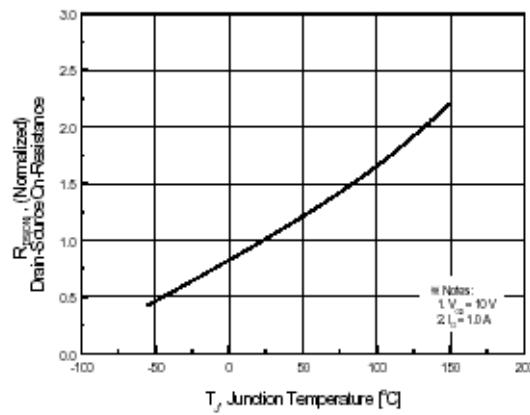


Figure 8. On-Resistance Variation vs Temperature

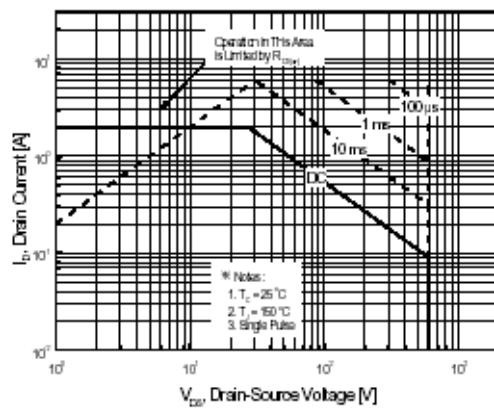


Figure 9-1. Maximum Safe Operating Area

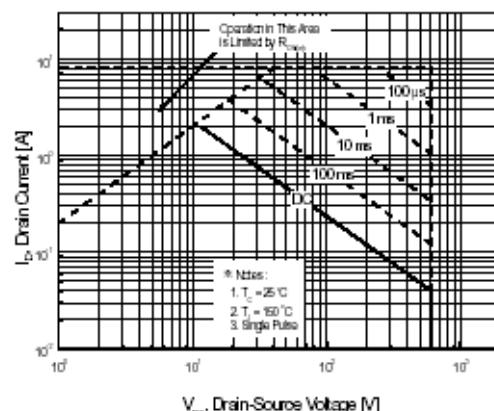


Figure 9-2. Maximum Safe Operating Area

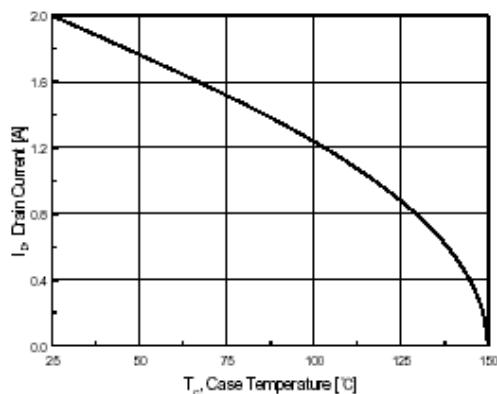
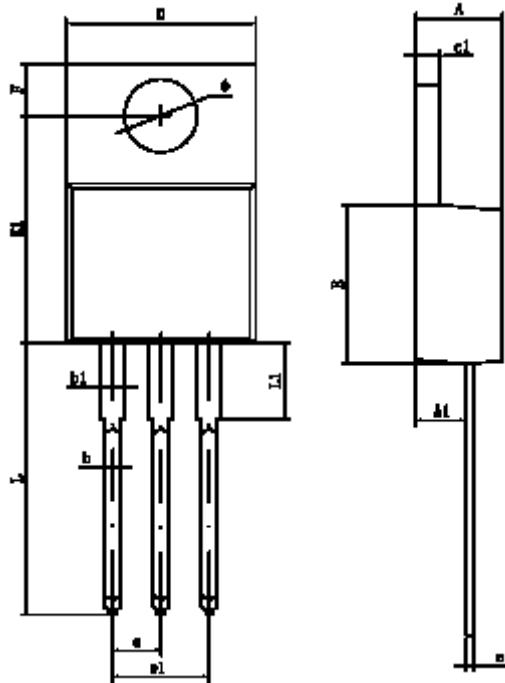


Figure 10. Maximum Drain Current vs Case Temperature

2.0A**TO-220-3L PACKAGE OUTLINE DIMENSIONS**

SAMBOL	DIMENSIONS IN MILLIMETERS	
	MIN	MAX
A	4.470	4.670
A1	2.520	2.820
B	0.710	0.910
b	1.170	0.910
b1	1.170	1.370
c	0.310	0.530
c1	1.170	1.370
D	10.01	10.31
E	8.500	8.900
E1	12.06	12.46
e	2.540 TYP	
e1	4.980	5.180
F	2.590	2.890
L	13.40	13.80
L1	3.560	3.960
	3.790	3.890

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